Dynamics and reversibility of oxygen doping and de-doping for conjugated polymer

Hua-Hsien Liao, Chia-Ming Yang, Chien-Cheng Liu, Sheng-Fu Horng, Hsin-Fei Meng, and Jow-Tsong Shy

1Department of Electric Engineering, National Tsing Hua University, Hsinchu 300, Taiwan, Republic of China
2Institute of Physics, National Chiao Tung University, Hsinchu 300, Taiwan, Republic of China
3Department of Physics, National Tsing Hua University, Hsinchu 300, Taiwan, Republic of China

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We perform comprehensive long-time monitoring of the p-doping and de-doping of poly(3-hexyl thiophene) under changing external conditions of oxygen, light, and temperature. They are shown to be controlled by the complex adsorption and desorption process with time scales ranging from seconds to weeks. The oxygen doping at atmospheric pressure takes several hours in the dark. The doping is dramatically accelerated to be within seconds with light of wavelength of 500–700 nm. Even at low oxygen pressure of 10−4 torr doping occurs within minutes with light. The de-doping by oxygen desorption takes as long as weeks at room temperature and vacuum of 10−4 torr, but when the temperature is raised to near the polymer glass temperature of 370 K, the de-doping is accelerated to minutes as the enhanced chain motion releases the trapped oxygen. Even though visible and near infrared light causes very efficient doping within seconds or minutes depending on vacuum level, such light-induced doping is not a chemical reaction and is fully reversible by thermal annealing at the end without sacrificing the mobility. For the polymer field-effect transistors, only the carrier density is changed while the mobility remains roughly a constant for all the conditions.

I. INTRODUCTION

Flexible electronics is the next generation technology which has received considerable attention recently. Conjugated polymers have been viewed as the most promising material due to their easy fabrications and remarkable opto-electronic properties. Polythiophenes are one class of conjugated polymers intensively studied due to their excellent performance in field-effect transistors (FETs) and solar cells. Especially for poly(3-hexylthiophene) (P3HT), the high off-current, defined as the source-drain current at zero gate bias for a FET, delays their progress towards commercialization. A FET with high off-current has a low on/off-current ratio. Such off-current also contributes an ohmic component to the solar cell and reduces the open-circuit voltage. Therefore, reducing the off-current of P3HT is a key issue for FETs and solar cells. It was known that oxygen is responsible for the p-doping which causes the off-current. The oxygen doping and de-doping processes depend on a variety of physical factors such as temperature, light, and vacuum. Abdou et al. reported O2 causes P3HT p-doping through charge transfer complex states and the doping is reversible by using vacuum. Thermal treatment is also shown to de-dope P3HT FET. O2 doping effect is found to be enhanced by light and it appears that this photo-induced doping effect is persistent and can be used as a new doping method. So far the dynamics of the doping process is not given and how the steady state is reached after the physical factor changes remains unclear. In addition to the dynamics of the oxygen doping process, the reversibility of the doping is a key question both from the fundamental and practical points of view. Only recently has it been understood that the P3HT dark oxygen doping process is a physical adsorption for oxygen on P3HT (Ref. 18) rather than a chemical reaction. One would therefore expect a full reversibility of oxygen doping after de-doping in vacuum. On the other hand, ambient light is known to significantly enhance the oxygen doping, which may result from some irreversible photo-chemical reactions common for organic semiconductors. On the practical side, the fabrication for polymer electronics also greatly depends on whether the doping is reversible or not as some levels of oxygen and light are inevitable in the fabrication. If reversible, the fabrication process does not need to be very strict on the environment control since the unwanted doping can be removed at the end by a de-doping step. On the other hand, if the doping is irreversible, every step of the process must be under strict control and the fabrication cost will be much higher. Despite a considerable number of reports on the sensitivity of P3HT and other conjugated polymers on oxygen at various temperature and illumination conditions, so far the full dynamics of the oxygen doping and de-doping process under changing physical environment is not mapped out and the reversibility remains unknown.

In this work using two-terminal conductivity and three-terminal field-effect transistor measurements we perform a long-time monitoring of the doping level of P3HT under a series of physical environments with different temperatures, oxygen pressures, vacuum levels, as well as light intensities...
and wavelengths. How the system approaches the steady state at each stage is recorded and the entire history of all the behaviors during several days is mapped out. It turns out the different processes are controlled by different time scales ranging from minutes to as long as days. In particular, no matter how heavily P3HT is doped, it is always reversible under heat treatment in vacuum if one waits long enough, with the only exception of illumination under an ultraviolet laser in the presence of oxygen. The process can be repeated in infinite cycles. A full picture is therefore established for the complex yet reversible physical interaction between molecular oxygen and P3HT films, which involves processes such as the diffusion through the polymer matrix, adsorption in the dark or facilitated by light, desorption at room temperature, and desorption above glass temperature.

II. EXPERIMENTAL PROCEDURE

In a two-terminal source-drain device (SD) Au electrodes are defined by a shadow mask with 50 μm channel length and 2 mm width on a glass substrate. The P3HT is purchased from Aldrich and dissolved in chloroform with 1 wt% for spin-coating on the previously patterned glass substrate in air to form a 1000 Å P3HT film. Each glass substrate has eight SD devices to check the experiment consistency. The three-terminal source-drain-gate transistor device is fabricated as in a previous report.1 The P3HT film is spin-coated like the SD device without a self-assemble monolayer. The sample is placed in a JANIS CCS-150 closed cycle system with a temperature controlled system. The closed cycle system is pumped by a Leybold turbo pumping station. Different pressure gauges are used to monitor the pressure in different ranges, including the Leibold TTR 91 vacuum gauge and MKS Baratron® 722 absolute vacuum gauge. I-V curves are measured by two Keithley 2400 controlled by Labview programs. \( I_{ds} \) is measured once every 5 s, and the voltage is only applied on the sample during the \( I_{ds} \) measurement. All of our \( I_{ds} \) time-evolution data are measured by this intermittent method to avoid the effect of mobile ionic impurities from the glass substrate.19

Light from a 250 W quartz-tungsten-halogen lamp passing through a monochromator is focused into the chamber on the sample. The monochromated light intensity is measured by a calibrated Si detector to calculate the relative photon flux \( n_p \). \( I_{ds} \) increment, \( \Delta I_{ds} \), was measured under a monochromated light illumination with a constant illumination time \( \Delta t \). The photo-induced oxygen doping rate is proportional to \( \Delta I_{ds}/\Delta t n_p \).

III. RESULTS AND DISCUSSIONS

A. Oxygen effect of two-terminal devices

A two-terminal source-drain (SD) device with 50 μm channel length is used. The off-current \( I_{ds} \) between the drain and source electrodes is measured for \( V_{SD} \) voltage from –200 to +200 V. The current-voltage curve is symmetric and linear, indicating that the current is determined by the bulk conductivity rather than the interface effect.20,21 Intermittent current measurement is used during the long monitoring period to avoid the mobile ionic effect from the glass substrate.19 For fixed carrier mobility, \( I_{ds} \) is proportional to the carrier density due to doping. Figure 1 shows the \( I_{ds} \) dynamics of a two-terminal P3HT SD device at 200 V under different conditions, and Table I summarizes the results. Initially, \( I_{ds} \) is 506 nA after a short exposure to air following the P3HT film deposition by spin-coating. When the sample is placed in dark vacuum (10^{-4} torr) at 300 K for 23 h (Procedure 1–1), \( I_{ds} \) is gradually reduced from 506 to 115 nA, consistent with the previous report that long time in vacuum causes O₂ de-doping.7 Decrease of \( I_{ds} \) is very slow and non-exponential, so it is difficult to reduce the off-current substantially by vacuum alone. Therefore the device is heated at 370 K for 5.7 h in the dark vacuum (Procedure 1–2). After a sudden rise due to an increase of mobility, \( I_{ds} \) starts to decrease at 370 K. After cooling back to 300 K, \( I_{ds} \) goes further down to 9 nA. Such low current level might be achieved by vacuum at 300 K as well, but it must take several days, even weeks.

After the thermal annealing, we study the light effect on \( I_{ds} \) under vacuum. The light of a fluorescent lamp is introduced into the vacuum chamber without focusing through the optical window of the closed-cycle cryogenic system (Procedure 1–3). The illumination lasting for 6.4 h, \( I_{ds} \) initially

![Figure 1](image-url)
increases from 9 to 35 nA within 20 min, then saturates for the next 6 h. The increased current is not a band-gap transition photocurrent because when the light is removed $I_{sd}$ does not return to the original level rapidly. Even in the vacuum below $10^{-4}$ torr $I_{sd}$ is still increased four times by the light within a short time interval, contrary to the previous assumptions.\textsuperscript{12,13} After a 370 K annealing for 1 h (Procedure 1–5), $I_{sd}$ is reduced to 5 nA, which is slightly lower than the current before Procedure 1–2, demonstrating that the photo-induced oxygen doping is reversible. In the subsequent procedures we clarify the correlation of O$_2$ and light: 650 torr of O$_2$, about four times the O$_2$ composition in air, is introduced into the chamber without focusing light from the same lamp. The rise of $I_{sd}$ is faster than in Procedure 1–2. The results demonstrate that even in the coexistence of high oxygen pressure and light, there is no chemical reaction and the photo-induced doping remains physical in nature and reversible under subsequent vacuum annealing. From Procedures 1–2 and 1–10, it is clear that de-doping is much more efficient at 370 K than at 300 K. The temperature dependency of the de-doping is studied by varying the temperature step by step. $I_{sd}$ at different annealing temperatures are shown in the inset of Fig. 1(a). The sample starts with a reduced doping level after staying in dark vacuum over 6 h at 300 K. As the temperature rises $I_{sd}$ increases due to the higher mobility. However, as the temperature is raised to 370 K, $I_{sd}$ develops a negative slope with time indicated by the arrowhead in the inset of Fig. 1(a). Note 370 K is near the glass temperature of P3HT.\textsuperscript{22} As we repeat the Procedure 1–1 with the long-time vacuum process for a heavily doped sample at elevated temperature, even at 310 K $I_{sd}$ starts to be reduced more efficiently than at 300 K. This implies that most of O$_2$ adsorbed on or near the surface of the heavily doped P3HT sample can be easily desorbed by vacuum, and small thermal energy can speed up this desorption process. After these shallowly adsorbed O$_2$ molecules are removed, the deeply trapped O$_2$ molecules can only be removed by a high temperature annealing process near the glass temperature of the polymer film. This temperature must be high enough to make P3HT chains mobile and release the O$_2$ molecules to the surface. The time scales for the doping and de-doping procedures are summarized in Table II. From the table it is seen that interestingly for the oxygen doping conditions.

### Table I. Time-correlated current of source-drain devices at different experimental conditions.

<table>
<thead>
<tr>
<th>Procedure</th>
<th>Time interval (h)</th>
<th>Light</th>
<th>Temperature (K)</th>
<th>O$_2$</th>
<th>Initial current (nA)</th>
<th>Final current (nA)</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>0–23</td>
<td>Dark</td>
<td>300</td>
<td>Vacuum</td>
<td>506</td>
<td>115</td>
</tr>
<tr>
<td>2</td>
<td>23–48</td>
<td>Dark</td>
<td>370 for 5.7 h</td>
<td>Vacuum</td>
<td>115</td>
<td>9</td>
</tr>
<tr>
<td>3</td>
<td>48–48.3</td>
<td>Light for 0.3 h</td>
<td>300</td>
<td>Vacuum</td>
<td>9</td>
<td>35</td>
</tr>
<tr>
<td>4</td>
<td>48.3–54.4</td>
<td>Dark</td>
<td>300</td>
<td>Vacuum</td>
<td>35</td>
<td>28</td>
</tr>
<tr>
<td>5</td>
<td>54.4–57</td>
<td>Dark</td>
<td>370 for 1 h</td>
<td>Vacuum</td>
<td>28</td>
<td>5.2</td>
</tr>
<tr>
<td>6</td>
<td>57–59.4</td>
<td>Dark</td>
<td>300</td>
<td>650 torr for 2 h</td>
<td>5.2</td>
<td>8.7</td>
</tr>
<tr>
<td>7</td>
<td>59.4–60.3</td>
<td>Light for 0.83 h</td>
<td>300</td>
<td>125 torr</td>
<td>8.7</td>
<td>628</td>
</tr>
<tr>
<td>8</td>
<td>60.3–61.5</td>
<td>Dark</td>
<td>300</td>
<td>125 torr for 1.2 h</td>
<td>628</td>
<td>328</td>
</tr>
<tr>
<td>9</td>
<td>61.5–61.7</td>
<td>Dark</td>
<td>300</td>
<td>Vacuum</td>
<td>328</td>
<td>290</td>
</tr>
<tr>
<td>10</td>
<td>61.7–63</td>
<td>Dark</td>
<td>370 for 1 h</td>
<td>Vacuum</td>
<td>290</td>
<td>11</td>
</tr>
</tbody>
</table>

### Table II. The oxygen doping and de-doping rate at different experimental environments.

<table>
<thead>
<tr>
<th>Doping condition</th>
<th>Rate</th>
</tr>
</thead>
<tbody>
<tr>
<td>Light+Vacuum</td>
<td>Moderate (~min)</td>
</tr>
<tr>
<td>O$_2$, dark</td>
<td>Slow (~h)</td>
</tr>
<tr>
<td>O$_2$, Light</td>
<td>Fast (~s)</td>
</tr>
</tbody>
</table>

<table>
<thead>
<tr>
<th>De-doping condition</th>
<th>Rate</th>
</tr>
</thead>
<tbody>
<tr>
<td>300 K+Vacuum+Dark</td>
<td>Very slow (~days to weeks)</td>
</tr>
<tr>
<td>370 K+Vacuum+Dark</td>
<td>Moderate (~min)</td>
</tr>
</tbody>
</table>
process the presence of light is more important a factor than the oxygen pressure itself. This suggests that ambient light must be under strict control if a low level of doping is to be maintained throughout that sample fabrication and operation. As for the de-doping, even though the doping can always be undone in vacuum, it will take an extremely long time, up to weeks at room temperature. Raising the temperature to 370 K, close to the glass transition temperature, can accelerate the process significantly to minutes.

B. Oxygen effect of field-effect transistors

So far we measured the current $I_{sd}$ which is proportional to the product of hole carrier density $p$ and mobility $\mu$, with the assumption that mobility is basically independent of $O_2$ adsorption so all the changes in current are due to carrier density. Below transistor measurement is carried out to verify this assumption. Two FET devices, FET-1 and FET-2, on the same substrate are monitored in procedures similar to the previous two-terminal device. Besides the off-current $I_{sd}$, the mobilities and on/off-current ratios of two FETs are also recorded at the same time. The FET off-current $I_{sd}$ is measured at drain-source voltage $V_{SD}=-40$ V and gate-source voltage $V_{GS}=0$ V in the dark except for cases to be specified. The off-current $I_{sd}$ is compared to the FET source-drain on-current at $V_{SD}=-40$ V and $V_{GS}=-40$ V to get the on/off ratio. The off-currents $I_{sd}$ are shown in Figs. 2(a)–2(c). The mobility of the device is fitted from the source-drain current at $V_{SD}=-40$ V as a function of $V_{GS}$ using the saturated region formula. The mobility and on/off-current ratio are plotted via procedures in Fig. 2(d). The typical FET characteristics are shown in the inset of Fig. 2(b).

After introducing the sample into the chamber, it is annealed at 370 K in vacuum for 2 h immediately to reduce the oxygen doping (Procedure 2–2). When the temperature is cooled down to 300 K, $I_{sd}$ is decreased to 275 and 175 nA for FET-1 and FET-2, respectively, and the on/off-current ratios for FET-1 and FET-2 are increased five times. At the same time, the field effect mobilities for both transistors decrease only slightly. This demonstrates that the significant decrease of $I_{sd}$ is mainly due to the carrier density $p$ instead of the mobility $\mu$ as expected. It also shows that the annealing process at this temperature only enhances the $O_2$ de-doping to reduce the carrier density but does not degrade the carrier mobility. Next, 650 torr of $O_2$ is introduced into the dark chamber (Procedure 2–3). The off-current $I_{sd}$, on/off-current ratios, and carrier mobilities are measured after 50 min. The off-current $I_{sd}$ for FET-1 and FET-2 increases by 1–2 nA. Both on/off-current ratios and carrier mobilities remain about the same. It illustrates that in the dark environment $O_2$ doping rate remains low even as the $O_2$ pressure is increased for...
several orders of magnitude, consistent with previous results of two-terminal devices shown in Fig. 1. Then the O₂ pressure is reduced to vacuum for 30 min and then raised to 125 torr; the light is also introduced in both O₂ pressures (Procedures 2–4 and 2–5). Within 20 min the $I_{sd}$ of the two devices increases substantially, and the on/off-current ratio decreases over ten times. The carrier mobilities slightly increase. Once again, it shows that the $I_{sd}$ changes were caused by the carrier density variations, not the carrier mobility. $I_{sd}$ increases faster when the light intensity increases. When the light and O₂ are removed, the chamber becomes dark vacuum again and $I_{sd}$ does not disappear immediately but decreases gradually with time (Procedure 2–6). The on/off-current ratios are increased by two times, but the carrier mobilities are only decreased slightly. After a 2 h annealing process at 370 K (Procedure 2–7), $I_{sd}$ and on/off-current ratio are back to the levels before photo-induced O₂ doping in Procedure 2–2. The simultaneous monitoring of both $I_{sd}$ and $\mu$ through Procedures 2–1 to 2–7 establishes that all the variations are dominated by the carrier density caused by O₂ doping while the mobility changes little, therefore the procedures are basically reversible. If the annealing time is longer, the off-current $I_{sd}$ will be even lower and the on/off ratio even higher.

Using transistors we show that P3HT O₂ doping and de-doping processes are almost reversible, except for the slightly decreased mobility. We suspect the slightly decreased mobility is caused by the irreversible photo-oxidation due to short-wavelength photon. To check this 136 torr of O₂ is introduced into the chamber, and a 405 nm laser beam is focused on FET-2. FET-1 inevitably receives some scattered laser light. Within 30 min, the off-current $I_{sd}$ of FET-2 is increased by almost 2 orders of magnitude. On the other hand, the dark current of FET-1 is only increased by 1 order of magnitude by the scattered 405 nm light (Procedure 2–8). The on/off ratios are reduced by 17 and 60 times for FET-1 and FET-2, respectively. The mobility of FET-2 starts to decrease upon 405 nm illumination, but the mobility for FET-1 remains the same. The off-current $I_{sd}$ rises sharply for FET-2, indicating strong photo-induced O₂ doping by the 405 nm laser. After 40 min of laser illumination $I_{sd}$ of FET-2 starts to decrease, but $I_{sd}$ of FET-1 remains increasing. From Fig. 2(d) the decrease of $I_{sd}$ of FET-2 is mainly due to its mobility decay. The transistor characteristics are measured three times during Procedure 2–8, indicated by 8A, 8B, and 8C in Fig. 2(d). After 2 h laser illuminations, the chamber is switched to the dark vacuum, and $I_{sd}$ of FET-1 and FET-2 both gradually decrease (Procedure 2–9). FET-2 mobility further decreases as shown in Fig. 2(d). In dark vacuum for a night, $I_{sd}$ of FET-1 and FET-2 decreases, but only the on/off ratio of FET-1 increases slightly. The severe degradation of the mobility of FET-2 compared with FET-1 suggests that the 405 nm laser illumination in the presence of oxygen causes irreversible chemical reactions, which cannot be undone by subsequent physical process. We verify this by the following de-doping procedure: the de-doping by thermal annealing at 370 K for 2 h (Procedure 2–10). While the $I_{sd}$ is reduced the on/off ratio cannot return to the previous level. The mobility of FET-2 remains low after the laser is turned off for a long time (Procedure 2–9) in Fig. 2(d), demonstrating that the laser does cause irreversible damage in Procedure 2–8. The coexistence of O₂ and focused 405 nm laser is therefore identified as the only procedure to break the reversibility of the P3HT system. It is interesting to check whether the laser-damaged P3HT films still have reversible O₂ doping property. A photo-induced O₂ doping and high temperature annealing processes are applied to FET-1 and FET-2 again (Procedures 2–11, 2–12, and 2–13). The 130 torr O₂ and white light from the lamp are introduced into the chamber at the same time, similar to Procedure 2–5. Within 10 min large $I_{sd}$ recovers for FET-1 but not for FET-2. Indeed, P3HT of FET-2 is so seriously damaged that the current can never be fully recovered by doping. After thermal de-doping in Procedure 2–13, the $I_{sd}$, on/off-current ratio, and mobilities all go back to the values before the photo-induced O₂ doping in Procedure 2–10. This illustrates that although P3HT are damaged, the O₂ doping process is still totally reversible under normal photon energy, intensity, O₂ pressure, and temperature ranges. The mobility and on/off-current ratio results are plotted in Fig. 2(d) via different procedures and are summarized in Table III.

C. Doping and light wavelength

Except for the 405 nm laser, so far the light employed for photo-induced O₂ doping is derived from a lamp with broad emission spectrum. It is important to know the range of the wavelength that causes the majority of the doping since they should be avoided in the sample fabrication in order to reduce the undesired off-current. Red light in the 600–700 nm range has been shown to enhance the oxygen doping, but the study is not extended into the shorter wavelength spectral region that overlaps with the absorption spectrum of P3HT. Below we study the wavelength dependence of the efficiency of the doping for the wide range of wavelengths covering the near infrared and the whole visible range. Such doping spectrum is also crucial to understanding the mechanism of the photo-induced doping which renders the high sensitivity of P3HT to the ambient light during sample fabrication where $t$ is time and $np$ is the relative photon flux from the lamp for a given wavelength.

The doping efficiency is defined as the $I_{sd}$ increment per unit time and per unit photon flux $\Delta I_{d}/(\Delta t \Delta n_p)$. In Fig. 3 $\Delta I_{d}/(\Delta t \Delta n_p)$ is plotted against the wavelength selected by a monochromator under 47 torr O₂ atmosphere. Positive $\Delta I_{d}/\Delta n_p$ means the light-induced O₂ doping rate is larger than the O₂ desorption rate. From Fig. 3, cases of incident light with wavelength larger than 680 nm all have small and negative $\Delta I_{d}/\Delta n_p$ values. When the wavelength is below 680 nm $\Delta I_{d}/\Delta n_p$ becomes positive and has a peak at 610 nm. The 500–600 nm photons within the absorption range dose enhance the O₂ doping process. The doping spectrum is, however, very different from the absorption spectrum, which is shown for comparison. To confirm the $I_{sd}$ increase is not the photocurrent from the interband absorption and the reversibility of photo-induced oxygen doping process, two two-terminal devices (SD-3 and SD-4) on the same substrate are compared, as shown in the inset of Fig. 3. SD-3 is di-
rectly illuminated by a focused monochromatic light, and SD-4 is only affected by weak scattered light from SD-3. \( \text{Isd} \) of SD-3 under the direct 500 nm light illumination in 47 torr \( \text{O}_2 \) atmosphere increases with time, while \( \text{Isd} \) of SD-4 remain constant. After \( \text{Isd} \) of SD-3 is increased by 15\%, the incident light is stopped and the sample is returned to the dark with the same \( \text{O}_2 \) pressure. The increased \( \text{Isd} \) of SD-3 does not disappear rapidly but is gradually reduced with time and back to the initial current levels after tens of minutes. The slow recovery suggests desorption of \( \text{O}_2 \) molecules from P3HT so the increased \( \text{Isd} \) is not due to the photocurrent from P3HT band-gap absorption, which would disappear immediately after light is turned off. This photo-induced \( \text{O}_2 \) doping effect is reversible for the 500 nm wavelength. The major difference between the doping and absorption spectra is that the doping spectrum is more pronounced in the long wavelength region and decreases rapidly for wavelength below 610 nm where the absorption increases. The spectral difference together with the long transient time indicates that the excitation is not the simple interband transition but a new excited state that does not exist in pure P3HT. In other words, the electronic structure of P3HT is modified by the adsorption of the molecular oxygen despite that no irreversible chemical reaction takes place. It has been shown by \textit{ab initio} calculation that adsorption of oxygen on a carbon nanotube changes the electronic structure from a semiconductor to a metal through the hybridization of oxygen and carbon wave functions. A nearly half-filled oxygen band forms by the hybridization with Fermi level pinned within. Even in the ground state there is a net electron transfer from the polymer to the oxygen band to cause a \( p \)-doping. Recently it was shown theoretically that similar semiconductor-metal transition happens for conjugated polymers with oxygen adsorption as well. The doping peak at 610 nm in Fig. 3 is presumably due to the transition from the filled and flat sulfur-dominated band to the nearly half-filled flat oxygen band. The net result is an electron transfer from P3HT to \( \text{O}_2 \) to form a complex. Under the applied electric field the hole in P3HT is driven away from the oxygen and a carrier is created. The existence of free holes may also enhance the adsorption of oxygens by acting as an oxygen trap to form a meta-stable complex. Note that there are two ways to create hole carriers by oxygen. One is the dark doping through the wave function hybridization, the other is the photo-doping through the creation of the complex. From the dynamics the efficiency of the photo-doping is much higher than the dark doping, but both of them are reversible under thermal annealing.

### D. Dynamic picture of doping and de-doping

From the doping/de-doping dynamics and reversibility above a picture of the interaction between oxygen molecules and P3HT is established. The state of the polymer is controlled by the dynamics of the oxygen adsorption and desorption processes (Fig. 4). For adsorption the oxygen molecules...
It has to be focused on the polymer in the presence of oxygen. Mobility is then degraded by the photo-oxidation and the current can no longer be recovered in subsequent process. These results indicate ultraviolet light must be avoided during the fabrication of polymer electronic devices. Visible and near infrared light do cause very efficient doping within a minute during fabrication, even at a medium vacuum level. But such doping is fully reversible by thermal annealing at the end without sacrificing the mobility. Despite the high oxygen and light sensitivity, the manufacturing process does not need to be strictly controlled since they do not inflict irreversible damage.

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